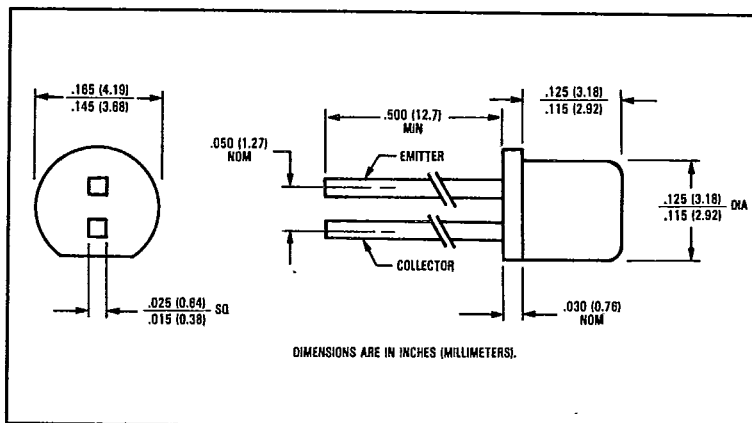
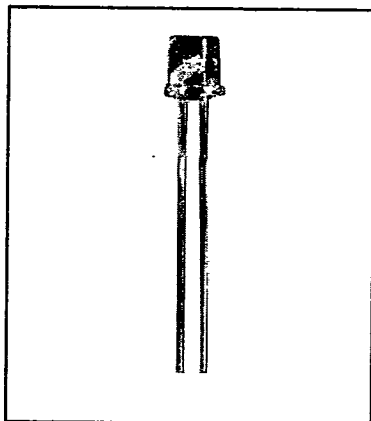


NPN Silicon Phototransistor Type OP500W



Features

- Flat lensed for wide acceptance angle
- .050" lead spacing
- Low cost plastic miniature plastic end-looking T-1 package.

Description

The OP500W consists of an NPN silicon phototransistor mounted in a flat lensed, clear plastic, end-looking package. The flat lens allows an acceptance half angle of 45° measured from the optical axis to the half power point. The OP500W is mechanically and spectrally matched to the OP160W infrared emitting diodes.

Absolute Maximum Ratings (T_A = 25°C unless otherwise noted)

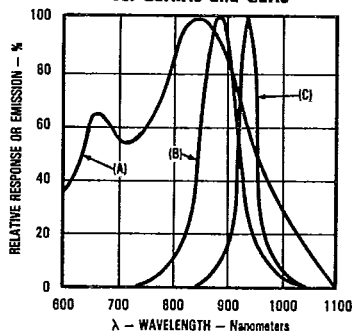
Collector-Emitter Voltage	30 V
Emitter-Collector Voltage	5.0 V
Storage and Operating Temperature Range	-40°C to +100°C
Lead Soldering Temperature (1/16 inch [1.6 mm] from case for 5 sec. with soldering iron) ⁽¹⁾	240°C
Power Dissipation	100 mW ⁽²⁾

Notes:

- (1) RMA flux is recommended. Duration can be extended to 10 sec. max. when wave soldering.
- (2) Derate linearly 1.33 mW/°C above 25°C.
- (3) Junction temperature maintained at 25°C.
- (4) Light source is an unfiltered tungsten bulb operating at CT = 2870°K or equivalent infrared source.
- (5) To calculate typical collector dark current in μA , use the formula $I_{CEO} = 10^{0.040 T_A - 3.4}$ where T_A is ambient temperature in °C.

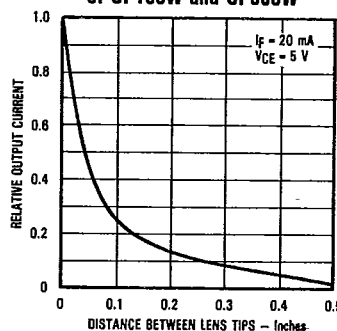
Typical Performance Curves

Photosensor Spectral Response
vs. GaAlAs and GaAs



Test Conditions (LED): T_A = T_J = 25°C, I_F = 100 mA,
DC = 0.1%, PW = 100 μs
Peak Wavelength - λ_p : (A) XSTR - 850 $\pm$ 30 nm, (B) LED
GaAlAs - 875 $\pm$ 20 nm, (C) LED GaAs - 930 $\pm$ 15 nm

Coupling Characteristics
of OP160W and OP500W



Type OP500W

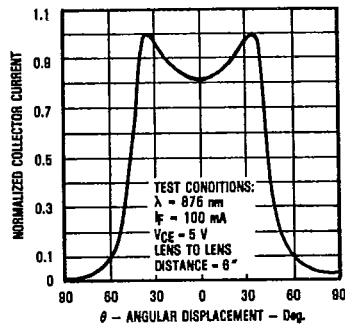
T-41-61

Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

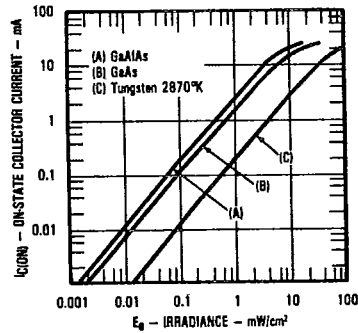
Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$I_{C(ON)}^{(3)}$	On-State Collector Current	0.50			mA	$V_{CE} = 5.0\text{ V}$, $E_g = 20\text{ mW/cm}^2$ ⁽⁴⁾
$\Delta I_C / \Delta T$	Relative I_C Changes with Temperature		1.00		%/°C	$V_{CE} = 5.0\text{ V}$, $E_g = 1.00\text{ mW/cm}^2$, $\lambda = 875\text{ nm}$
$I_{CE0}^{(5)}$	Collector Dark Current			100	nA	$V_{CE} = 15.0\text{ V}$, $E_g = 0$
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage	30			V	$I_C = 100\text{ }\mu\text{A}$
$V_{(BR)ECO}$	Emitter-Collector Breakdown Voltage	5.0			V	$I_E = 100\text{ }\mu\text{A}$
$V_{CE(SAT)}^{(3)}$	Collector-Emitter Saturation Voltage			0.40	V	$I_C = 250\text{ }\mu\text{A}$, $E_g = 20\text{ mW/cm}^2$ ⁽⁴⁾

Typical Performance Curves

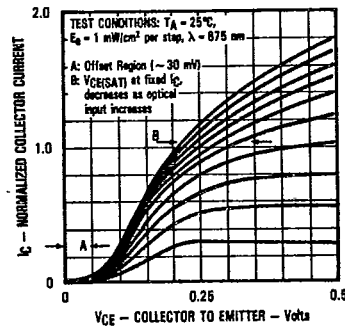
Normalized Collector Current vs. Angular Displacement



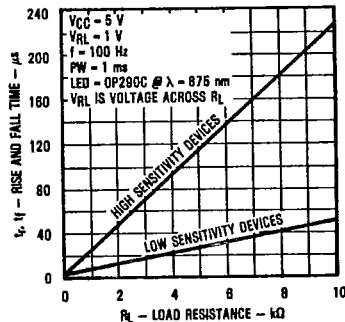
On-State Collector Current vs. Irradiance



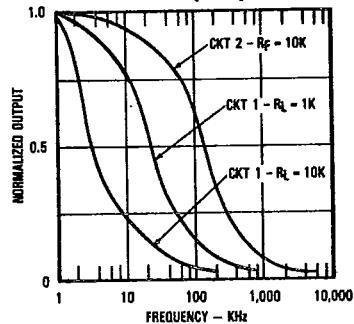
Normalized Collector Current vs. Collector to Emitter Voltage



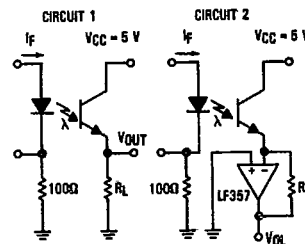
Rise and Fall Time vs. Load Resistance



Normalized Output vs. Frequency



Switching Time Test Circuit



Test Conditions:
Light source is pulsed LED with t_r and $t_f \leq 500\text{ ns}$.
 I_F is adjusted for $V_{OUT} = 1\text{ Volt}$.

TRW reserves the right to make changes at any time in order to improve design and to supply the best product possible.

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